Search Notes

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Application/Control No.	Applicant(s)/Patent Under Reexamination
10560758	MEYER ET AL.
Examiner	Art Unit
JAEYUN LEE	1791

SEARCHED			
Class	Subclass	Date	Examiner
156	105, 106, 107	7/29/2009	/JL/

SEARCH NOTES		
Search Notes	Date	Examiner
East search (US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, Derwent,	7/22/2009	/JL/
IBM_TDB) and text search		
Consulted Primary Examiner (Jeff Aftergut)	7/22/2009	/JL/

INTERFERENCE SEARCH			
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